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AN ICRF ANTENNA EDGE PLASMA DENCITY PROFILE DIAGNOSTIC FOR DIII-D*

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SEVENTEENTH INTERNATIONAL CONFERENCE ON INFRARED & MILLIMETER WAVES PASADENA, CA. 14 DECEMBER 1992

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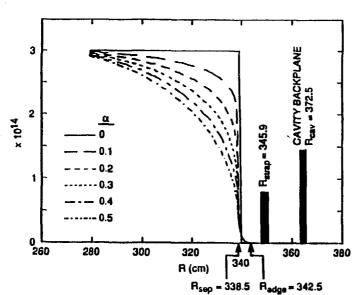
^{*} Research sponsored by the Office of Fusion Energy, U.S. Department of Energy under contract DE-AC05-84OR21400 with Martin Marietta Energy Systems, Inc.

INTRODUCTION

- High power waves in the Ion Cyclotron Range of Frequencies (ICRF) are used for heating and current drive of plasmas in experimental fusion devices.
- ICRF power is launched from high current antennas located at the plasma edge.
 ICRF waves tunnel through the low density evanescent region at the plasma edge
- Antenna loading and antenna launch spectrum are important parameters affecting ICRF heating & current drive system performance
 - -Increasing loading reduces the antenna voltage and current
 - -Optimum launch spectrum maximizes current drive or heating efficiency
- Antenna coupling and launch spectrum are strongly influenced by the plasma edge density profile and edge location
 - -A 50% loading decrease typically results as a profile changes from gradual to steep
- There is evidence that high ICRF power levels steepen the density profile in front of the antenna due to ponderomotive and/or electric field effects driving off the plasma
- Edge density profile data is desired for ICRF antenna coupling studies
 - -Both the slope and edge location are important
 - -Measurement of the profile perturbation is desired
- ICRF heating & current drive are key experiments on the DIII-D tokamak at General Atomics
 - -A 2 MW transmitter operating from 30-60 MHz is presently available
 - -A four-strap antenna is used to couple power to the plasma
 - -Heating and current drive experiments are performed by adjusting phasing
- A microwave reflectometer system with a launcher as close as possible to the ICRF antenna is being developed for density profile measurements
 - + The experiment is a collaboration between ORNL, UCLA and GA
 - + The configuration uses existing UCLA reflectometer electronics
 - + ORNL is fabricating a new launcher mounted next to the ICRF antenna
 - + First operation with the new configuration is likely during early 1993

THEORETICAL ANTENNA LOADING CALCULATIONS

 $n_o(R)$ FOR BPX ($R_{axis} = 279$ cm)



Power-parabolic density profiles $\{\sim |1-(r/r_{sep})^2|^{\alpha}\}$ converging to flat $(\alpha\to 0)$ profile.

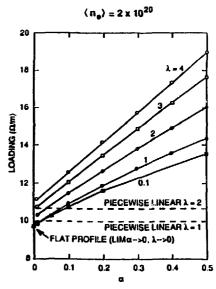


Fig. 6.26. Antenna loading, R', versus profile shape exponent, α .

BY D.B. BATCHELOR, ET AL. FOR BPX

MICROWAVE REFLECTOMETRY

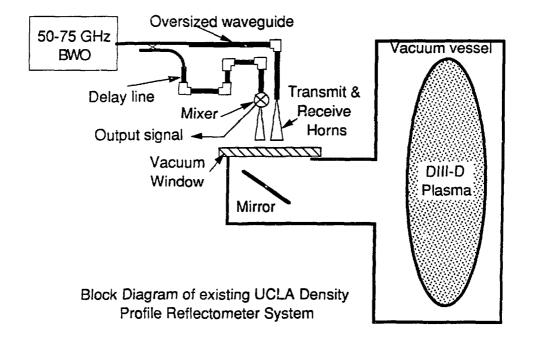
- Microwave reflectometry has evolved as a successful technique for both plasma density profile and density fluctuation measurements
- A microwave reflectometer probes the location of the plasma cutoff layer
 - + A high frequency probe beam is launched into the plasma normal to the edge
 - + The beam propagates into the plasma until a density cut-off layer is reached which reflects the wave back toward the edge
 - + A receiving antenna collects a portion of the reflected signal
 - + The cutoff location is determined from the phase of the reflected signal
 - + Separate (bistatic) transmit & receive horns are desired to eliminate interference from transmission line reflections
- Profile measurements are performed using a swept frequency signal
 - +Phase shift vs. frequency is measured and inverted to estimate the profile

$$\begin{split} & \phi_{measured} = \phi_{waveguide} + \phi_{vacuum} + \phi_{plasma} \\ & \phi_{plasma}(f) = 2 \ k_0 \int_{r_{edge}}^{r_{cutoff}} \mu_r(n_e, \mathbf{B}_0, f) \ dr - \frac{\pi}{2} \end{split}$$

- +Total phase can amount to hundreds of 2π fringes
- +The extraordinary plasma wave can measure a larger density range for a given frequency range and provide more resolution at low density
- Microwave reflectometers are ideally suited for density profile measurements near a high power ICRF antenna
 - +A true local profile measurement is obtained- not Abel-inverted cord measurements
 - +High speed, nearly continuous profile data is available
 - +The launchers are "hardened" against the plasma and high power ICRF fields
- Density fluctuations in the plasma make profile measurements difficult
 - -Large fluctuation levels cause unrealistic fringe jumps
 - Fluctuations cause random refractive effects which lead to amplitude fading
 - +High speed frequency sweep reduces the interference
 - +A dual-frequency differential-phase reflectometer with high dynamic range has been developed to reduce the fringe count and eliminate some of these effects

REFLECTOMETRY ON DIII-D

- Several successful reflectometer systems have been built and operated on DIII-D by UCLA
 - +Fixed and swept frequency types
 - +Profile measurements
 - +Fluctuation measurements
 - +High field launch system
- Profile measurements performed in 1990 using Q & V-band systems (Ref. E. J. Doyle, et al RSI61)
 - +47-75 GHz sweep for 2.1 T operation
 - +BWO source swept in 500 µsec
 - +Phase detector and delay line for reference
 - +Density range 0.2 to 4 x10¹⁹ m⁻³
 - +Ohmic, L- and H-mode discharge profiles were successfully measured



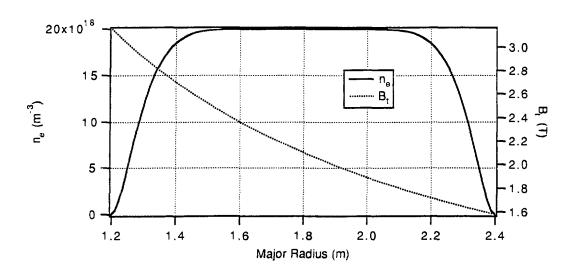
A ICRF ANTENNA MOUNTED REFLECTOMETER ANTENNA SYSTEM FOR DIII-D

- A program was initiated on 2 tokamaks in 1991 to measure the plasma density profile in front of ICRF antennas to assist in improving their performance and modeling the results
 - +The existing ORNL antenna on DIII-D was being modified and it was convenient to add reflectometer antennas
 - +A differential reflectometer was developed for TFTR for use with a launcher mounted inside a new antenna
- A dual frequency system was designed to match the existing UCLA reflectometer

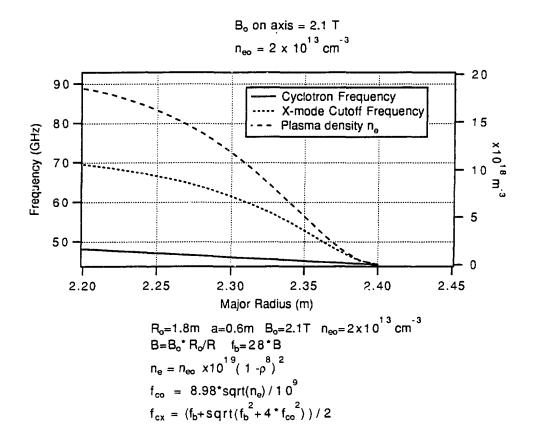
V-band: 50-75 GHz Q-band: 33-50 GHz

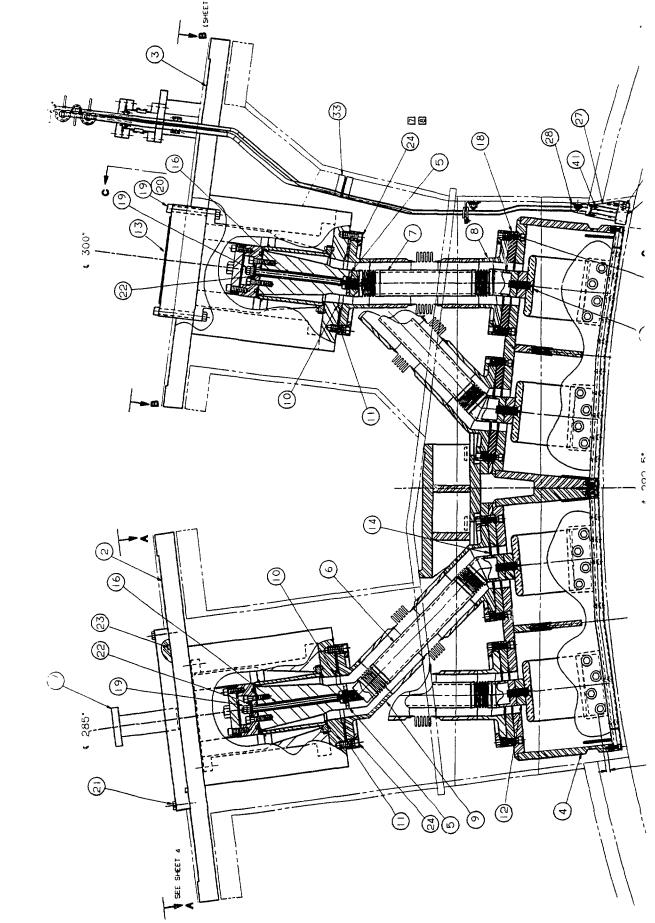
- Dual horn launchers are required to eliminate spurious response from waveguide reflections (windows, flanges, etc.)
- High quality horn radiation patterns are desired
 - -Low sidelobe levels and high polarization purity
 - -E-plane tilted ~12° to match X-mode polarization at the plasma edge
- Mechanical restrictions around the antenna made the launcher design difficult
 - -Small space for horns and transitions: broadband corrugated horns ruled out
 - -Feed waveguides insulated and braced for plasma disruptions
 - -Small port size for waveguide entry
 - -Wide band vacuum windows which meet bake-out requirements
- A graphite shield is desired for all plasma facing components

D-IIID Plasma Profile Simulation



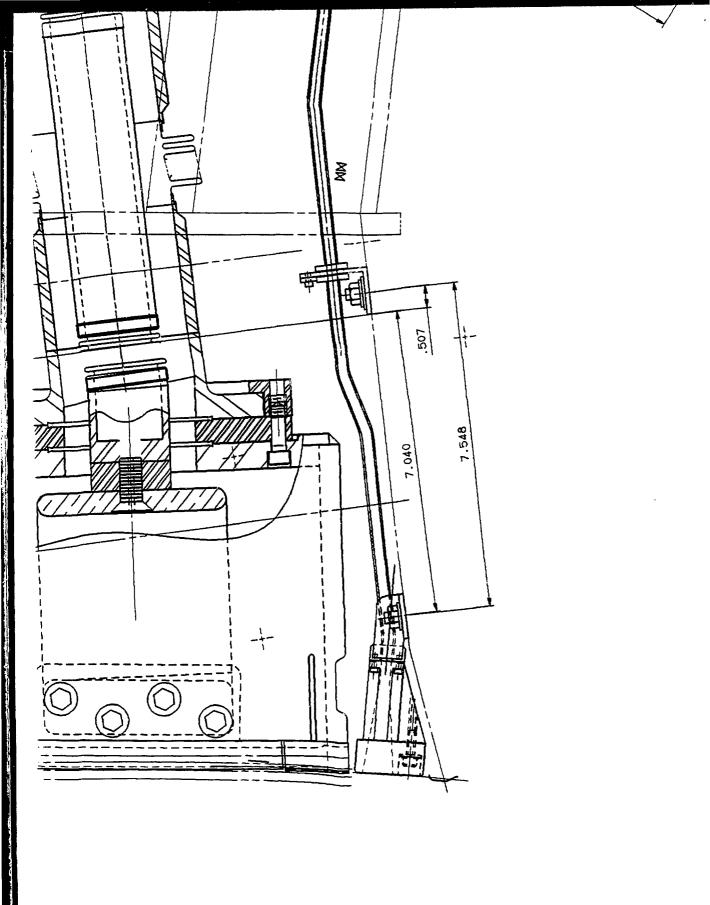
H-mode parabolic density profile $n_e = n_{eo} (1-p^8)^2$

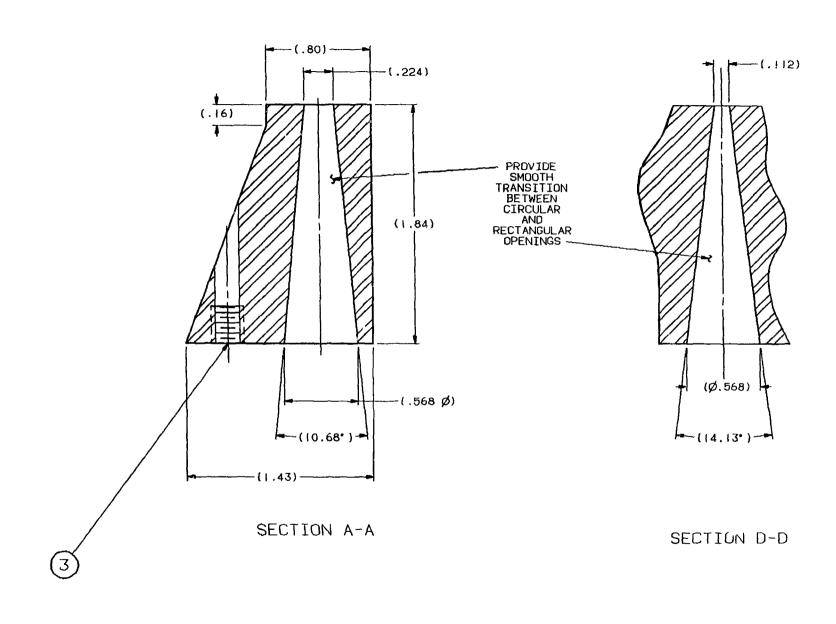




REFLECTOMETER ANTENNA AND WAVEGUIDE FABRICATION

- Waveguide horns and transitions were formed in a single stainless steel block
 +Wire electro-discharge machining (EDM) of rectangular to circular transition
 - +Outer 2-cm of the horns formed into a graphite block with a slight flare
 - +V-band circular apertures 1.6 cm diameter with 10.6° flare
 - +Q-band circular apertures 1.8 cm diameter with 10.6° flare
 - +Horn assembly attached to the DIII-D vessel wall with a bracket & studs
- Coin silver waveguide used to connect horns to outside the vacuum vessel
 - +Silver is preferred for forming complicated routes
 - +Low temperature ~600°C braze used to preserve temper
 - +Special "quad" flanges used for joints with raised bosses to minimize signal cross-coupling
 - +Waveguide insulated at the port end with a vacuum break and with BN bushings at a support bracket
- Waveguide vacuum windows
 - +Thin mica used to reduce reflections (0.076 mm or 0.003" thick)
 - +Dual windows not used due to excessive frequency variation in VSWR
 - +Viton O-rings for vacuum seal
 - +Temperature rating to 150°C
 - +Back-up vacuum can designed to cover up window assembly if a leak occurs





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PERFORMANCE MEASUREMENTS

• Antenna patterns closely match predictions

V-band @ 62.5 GHz: ~18° HPBW

Q-band @ 40 GHz: ~30° HPBW

· Reflections from windows

V-band: ~-10dB RL = 1.9:1 VSWR

Q-band: \sim -10dB RL = 1.9:1 VSWR

• Waveguide loss (total R+T)

V-band: 4dB

Q-band: 3dB

Cross coupling between horns minimized

Slots used to reduce direct signal further

V-band: <-53dB

Q-band: <-45dB

• Signal vs. distance from horn aperture using a flat plate reflector

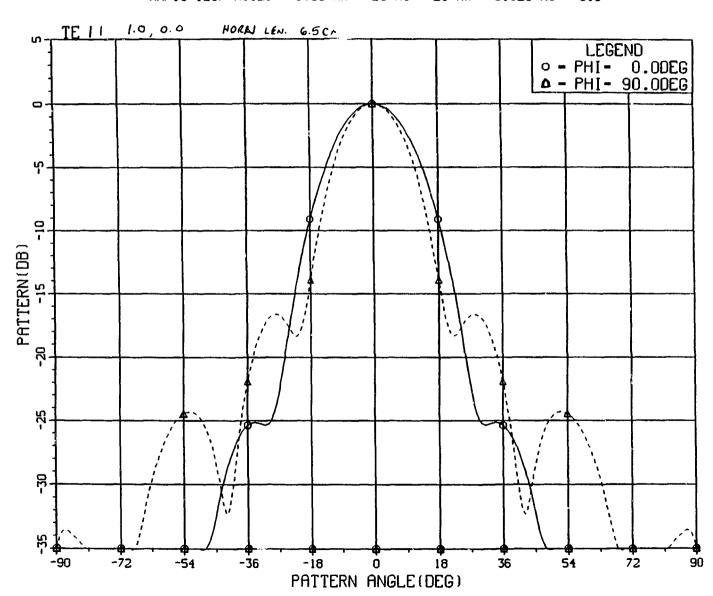
V-band: 10-20dB as plate varies from 5-55 cm

Q-band: 10-25dB as plate varies from 5-55 cm

• Small second order interference seen from 2-bounce signals. Graphite face beyeled to reduce the effect

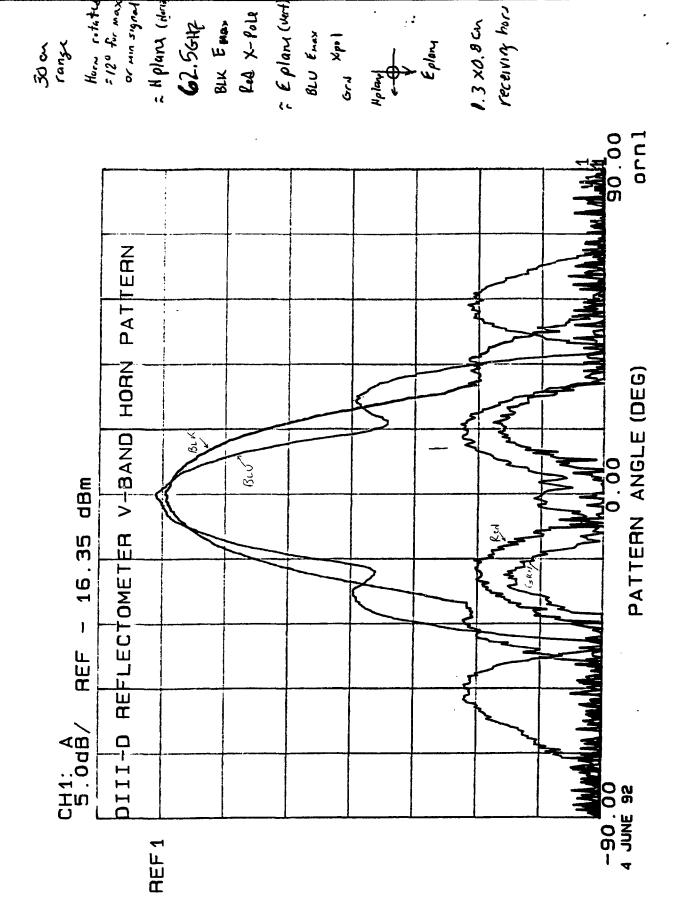
NEAR FIELD PATTERN

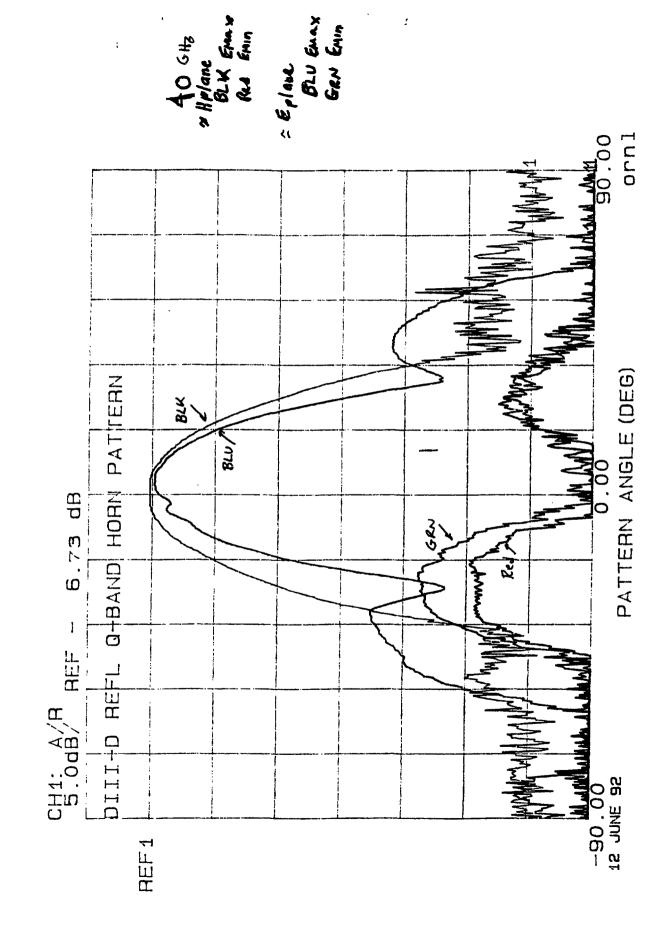
Smooth hall Horn 20 au range length

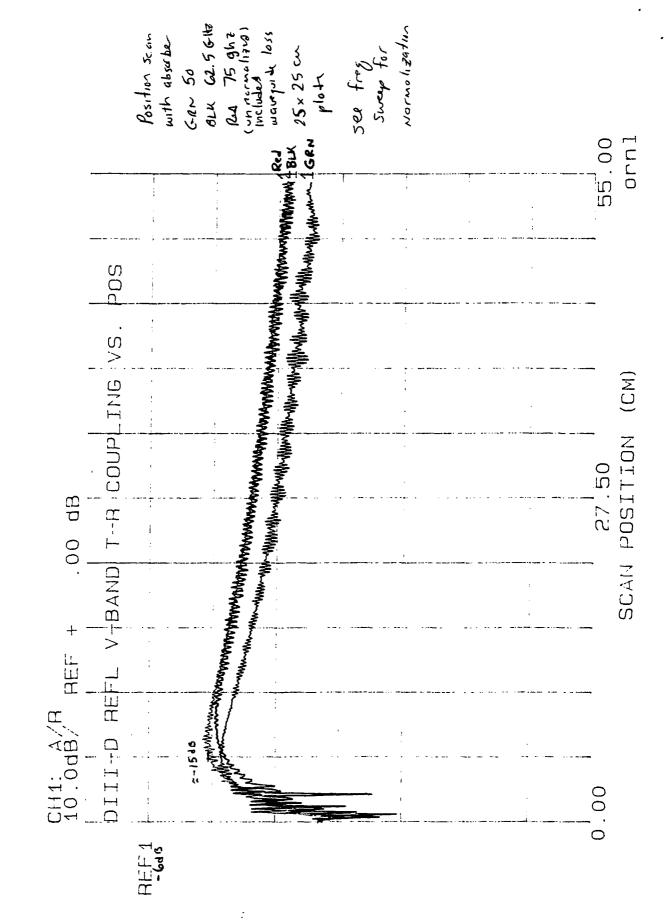


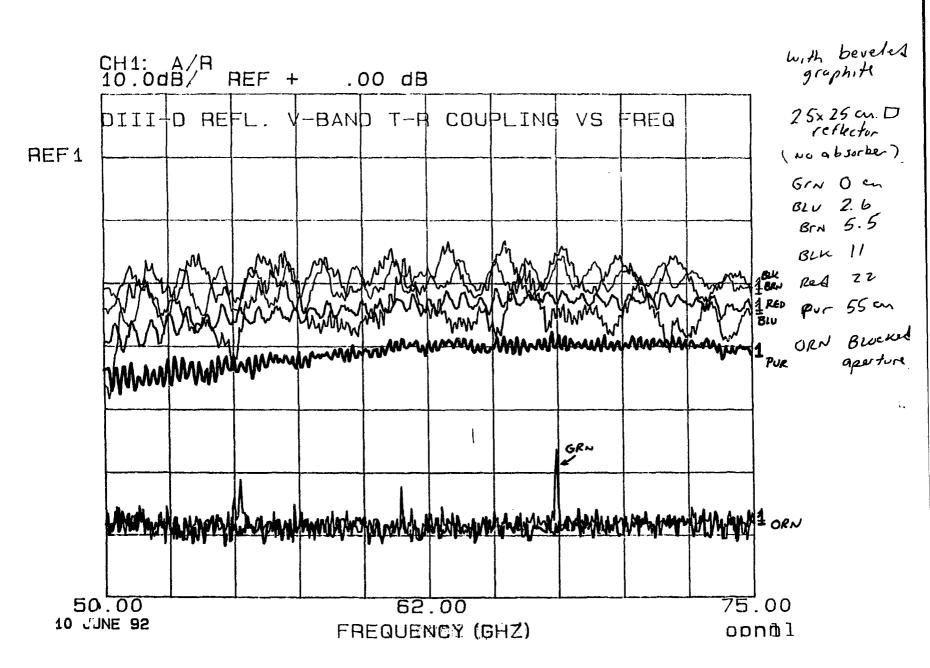
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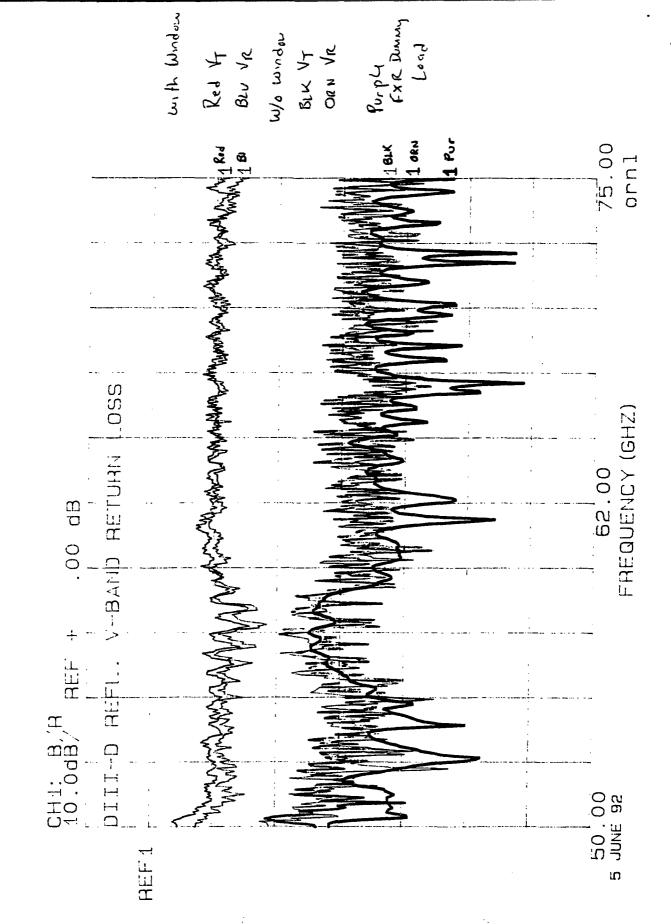
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PLANNED MEASUREMENTS WITH THE UCLA REFLECTOMETER ELECTRONICS

- Waveguide is being installed to connect the ICRF antenna mounted horns to the UCLA electronics system which is located several ports away
- Installation will be completed soon
- Calibration necessary for phase reference to be performed using in-vessel dummy reflector
 - -some post calibration may be necessary since access to horns is limited
- Several experiments have been proposed
 - +Study the effect of profile changes on loading
 - +Study the effect of the ICRF power level on the profile
 - +Is there significant toroidal variation in the profile perturbation?
 - +Comparison between reflectometer horn configurations on performance

PROPOSED FUTURE MEASUREMENTS USING THE ORNL TFTR REFLECTOMETER SYSTEM

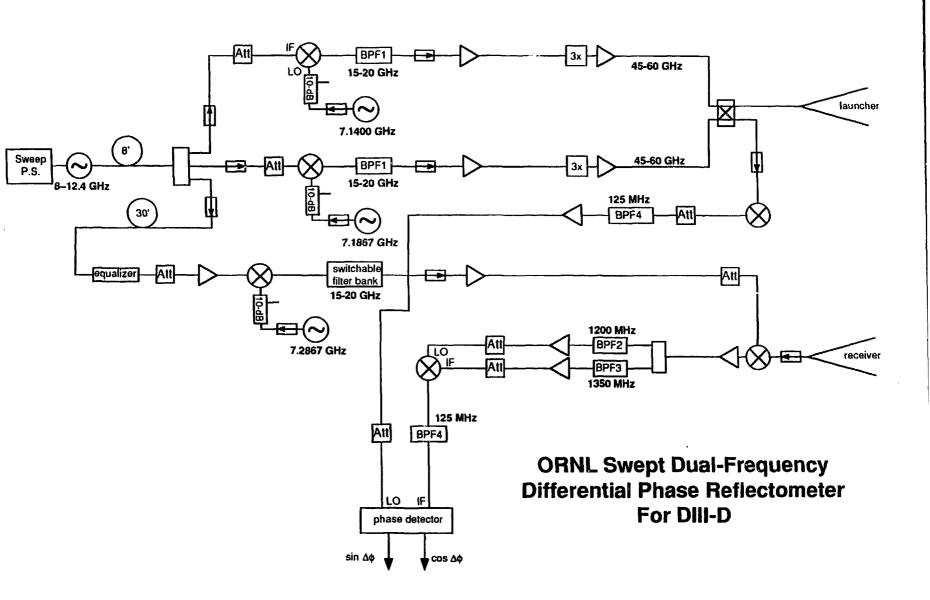
- A dual-frequency reflectometer system was developed at ORNL for ICRF antenna density profile measurement on the TFTR tokamak at PPPL
- The dual-frequency system uses two swept frequency probe beams for a differential phase measurement

Several advantages result:

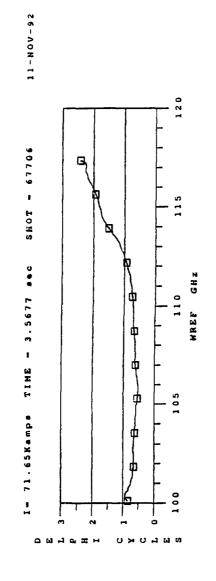
- +Reduction of the fringe count to <5
- + Cancellation of the effect of a large portion of the density fluctuations
- +Larger dynamic range possible since the system is a heterodyne type
- +All solid-state electronics
- +Significantly faster sweep speeds are possible
- +Long waveguide runs produce no fringes and significantly reduce calibration problems

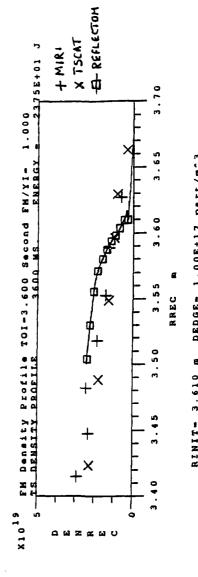
Some disadvantages exist which have been largely worked out:

- -A large number of components increases the costs
- -Some interference occurs at certain frequencies where mixer intermodulation products overlap with the IF frequency
- Initial measurements using this system have been performed on TFTR and the results are encouraging. Some improvements are being implemented for the D-T operation phase of TFTR
- This system will no longer be needed on TFTR in ~1.5 years at which time it can be easily modified to sweep from 45-60 GHz which is suitable for DIII-D edge plasma profiling
- Moving the electronics to DIII-D and incorporating them into the UCLA system has been proposed and could occur in 1994.



TYPICAL MEASURED PROFILE DATA





MM- 0.2500 GHz